

# 承 認 書 SPECIFICATION FOR APPROVAL

客戶名稱 CUSTOMER	:		
客戶料號 CUSTOMER'S P/N	:		
料號 PART NUMBER	: <u>WAN1803DL</u>	4GH05	
規格 DESCRIPTION		803 M-Ant 824M-	~960M & 1.7G~2.70
版本 VERSION	: <u>V1.2</u>		
日期 ISSUE DATE	: 2023/06/12		1877 ·
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	20	工程部	
A	承 認 APPROVAL	R&D CENTER 確認 CHECKED	製 作 DRAWN
0	Ray	Tennyson	Snow



# 萬誠科技股份有限公司

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# 1803 Chip antenna

# For LTE Applications 824~960MHz & 1700~2700MHz



**P/N:** WAN1803DL4GH05

	A COURT	
		Dimension (mm)
4	L	18.0 ± 0.20
10	W	3.00 ± 0.20
	T	1.10 ± 0.20



#### **Part Number Information**

WAN 1803 D L4G H 05

A B C D E F

A	Product Series	Antenna
В	Dimension W x L	18.0X3.0mm (+-0.2mm)
C	Material	High K material
D	Working Frequency	824~960MHz &
		1700~2700MHz
E	Feeding mode	Monopole & Single Feeding
F	Antenna type	Type = 05

# 1. Electrical Specification

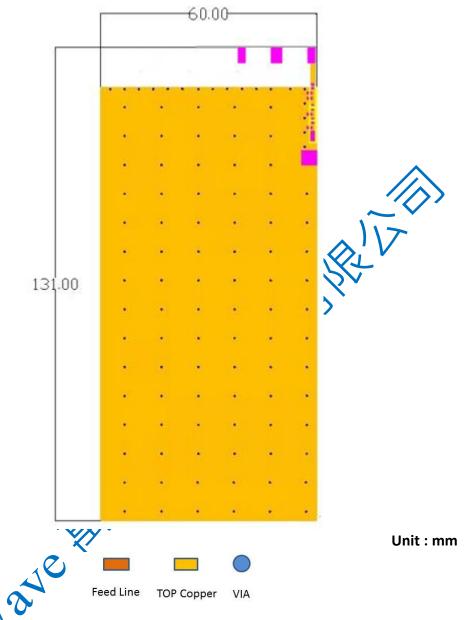
Specification						
Part Number	WAN1803DL4GH05					
Central Frequency	824~960MHz & 1700~2700MHz	MHz				
Bandwidth	140 (Min.) / 1000 (Min.)	MHz				
Return Loss	-6(Max)	dB				
Peak Gain	2.88 / 1.91	dBi				
Impedance	50	Ohm				
Operating Temperature	-40~+110	$^{\circ}\mathbb{C}$				
Maximum Power	4	W				
Resistance to Soldering Heats	10 ( @ 260℃)	sec.				
Polarization	Linear					
Azimuth Beamwidth	Omni-directional					
Termination	Cu / Sn (Leadless)					

Remark: Bandwidth & Peak Gain was measured under evaluation board of next page



#### 2. Recommended PCB Pattern

#### 1. Evaluation Board Dimension



# Suggested Matching Circuit

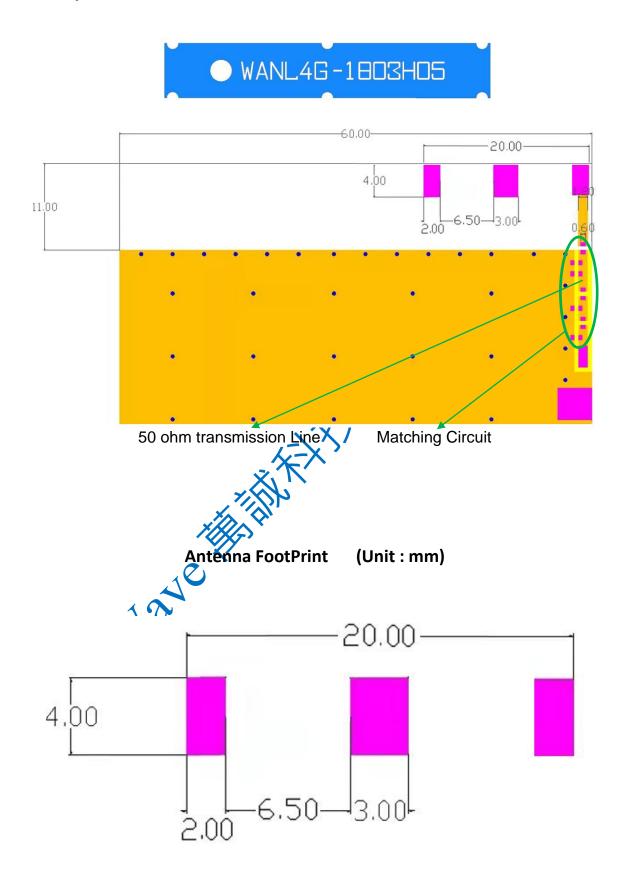
重要資訊

匹配, 华建議使用精準度高的電威±0.1~0.3nH、電容±0.1pF

# Matching Circuit 1.2pF 5.1nH Feeding 12nH 3 0.8pF None 1.3pF



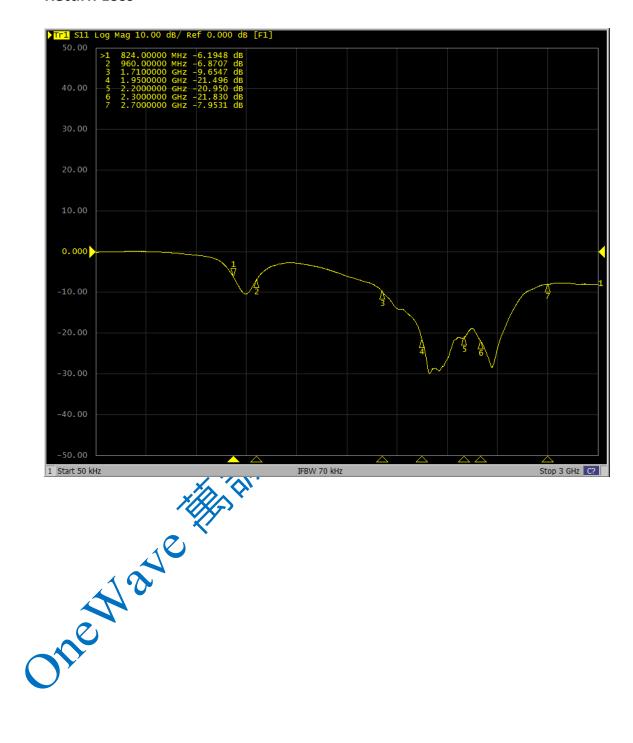
## 1. Layout Dimensions in Clearance area(Size=60\*11mm)





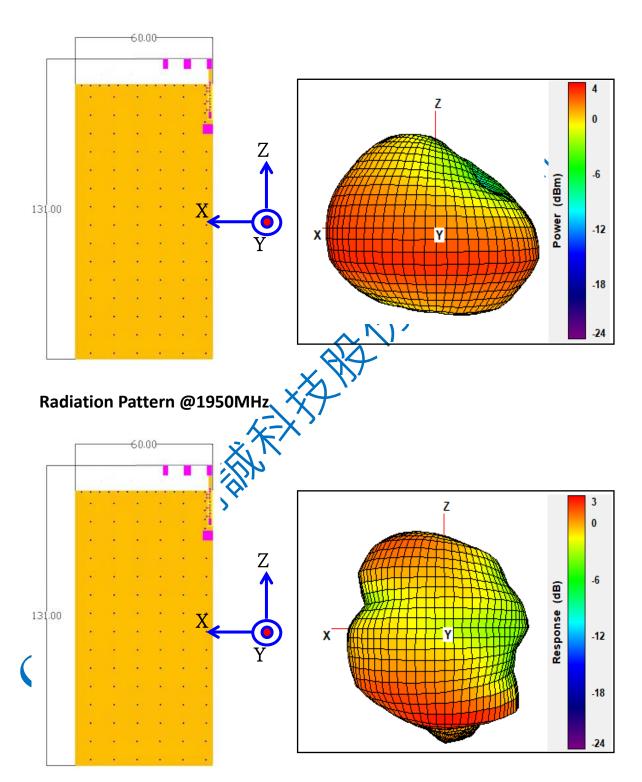
#### 3. Measurement Results

#### **Return Loss**



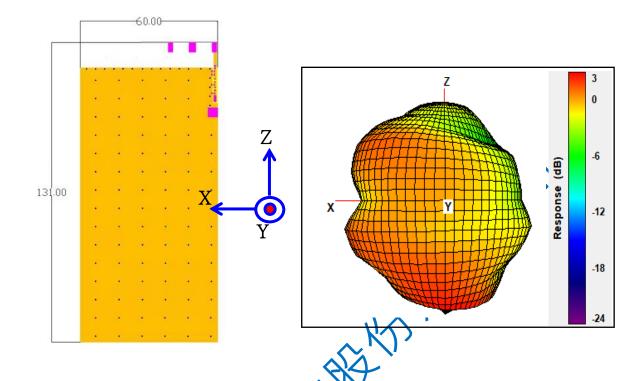


#### Radiation Pattern @960MHz





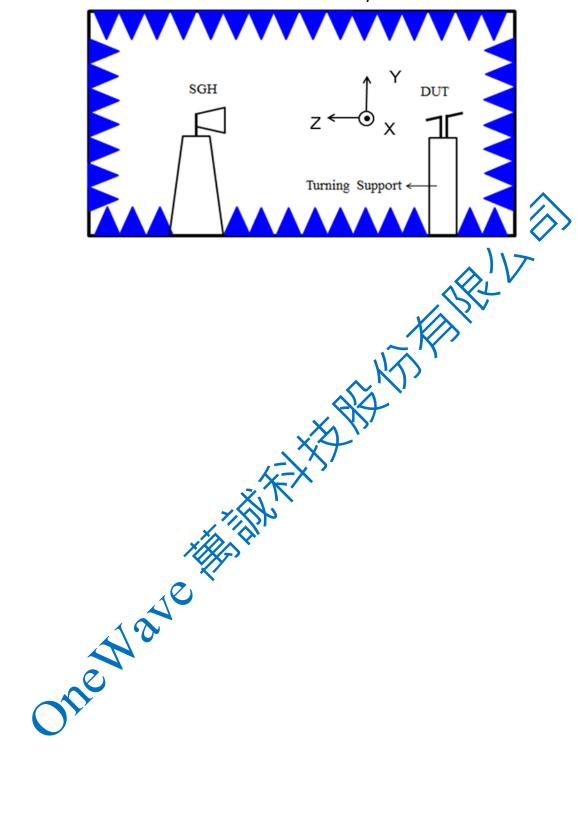
# Radiation Pattern @2300MHz



		Efficiency	Reak Gain	Directivity
	824 MHz	68.18 %	2.75 dBi	4.41 dBi
	960 MHz	72.36 %	2.88 dBi	4.29 dBi
	1700 MHz	73.66 %	1.71 dBi	3.03 dBi
	1950 MHz	75.89 %	1.84 dBi	3.04 dBi
	2200 MHz	76.34 %	1.86 dBi	3.03 dBi
•	2300 MHz	76.83 %	1.91 dBi	3.05 dBi
	2700 MHz	74.88 %	1.86 dBi	3.11 dBi



## **Chamber Coordinate System**





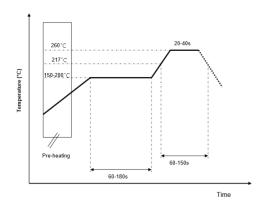
**4.Reliability and Test Condictions** 

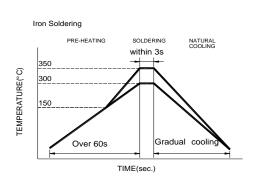
ITEM	REQUIREMENTS	TEST CONDITION		
Solderability	Wetting shall exceed 90% coverage     No visible mechanical damage	Pre-heating temperature:150°C/60sec. Solder temperature:230±5°C Duration:4±1sec.		
	TEMP (℃)	Solder:Sn-Ag3.0-Cu0.5		
	230°ℂ 4±1 sec.	Flux for lead free: rosin		
	150°C			
	60sec			
Solder heat	No visible mechanical damage	Pre-heating temperature:150°C /60sec.		
Resistance	2. Central Freq. change :within ± 6%	Solder temperature:260±5°C		
	TEMP (°C)	Duration:10±0.5sec. Solder:Sn-Ag3.0-Cu0.5		
	260°C 10±0.5 sec.	Flux for lead free: rosin		
	150°C			
	60sec			
Component	No visible mechanical damage	The device should be reflow		
Adhesion (Push test)		soldered(230±5°C for 10sec.) to a tinned copper substrate A dynometer force		
(i dan test)		gauge should be applied the side of the		
		component. The device must with-ST-F		
	A.	0.5 Kg without failure of the termination		
Component	No visible mechanical damage	attached to component.  Insert 10cm wire into the remaining open		
Adhesion	The state of the s	eye bend ,the ends of even wire lengths		
(Pull test)	λ-X',	upward and wind together.		
	3/1	Terminal shall not be remarkably		
		damaged.		
Thermal shock	No visible mechanical damage	+110°C =>30±3min		
	2. Central Freq. change :within ±6%	-40°C=>30±3min Test cycle:10 cycles		
	Phase Temperature(°C) Time(min)	The chip shall be stabilized at normal		
	1 +110±5℃ 30±3	condition for 2~3 hours before		
	2 Room Within	measuring.		
	Temperature 3sec			
	3 -40±2°C 30±3 Room Within			
	Temperature 3sec			
	<u></u>			
Resistance to	1. No visible mechanical damage	Temperature: +110±5°C		
High	2. Central Freq. change :within ±6%	Duration: 1000±12hrs		
Temperature	3. No disconnection or short circuit.	The chip shall be stabilized at normal condition for 2~3 hours before		
		measuring.		
Resistance to	No visible mechanical damage	Temperature:-40±5°C		
Low	Central Freq. change :within ±6%	Duration: 1000±12hrs		
Temperature	3. No disconnection or short circuit.	The chip shall be stabilized at normal		
	and an area and area area area area area area area are	condition for 2~3 hours before		
Humidity		measuring. Temperature: 40±2°C		
Humidity	1. No visible mechanical damage	Humidity: 90% to 95% RH		
	2. Central Freq. change :within ±6%	Duration: 1000±12hrs		
	3. No disconnection or short circuit.	The chip shall be stabilized at normal		
		condition for 2~3 hours before		
		measuring.		



#### 5. Soldering and Mounting

Mildly activated rosin fluxes are preferred. The minimum amount of solder can lead to damage from the stresses caused by the difference in coefficients of expansion between solder, chip and substrate. The terminations are suitable for all wave and re-flow soldering systems. If hand soldering cannot be avoided, the preferred technique is the utilization of hot air soldering tools.





Recommended temperature profiles for re-flow soldering in Figure 1.

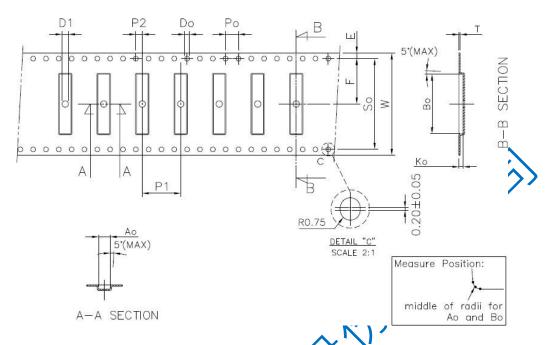
Products attachment with a soldering iron is discouraged due to the inherent process control limitations. In the event that a soldering iron must be employed the following precautions are recommended.

- Preheat circuit and products to 150°C
- · Never contact the ceramic with the iron tip
- Use a 20 watt soldering iron with tip diameter of 1.0mm
- 280°C tip temperature (max)
- 1.0mm tip diameter (max)
- Imit soldering time to 3 sec.



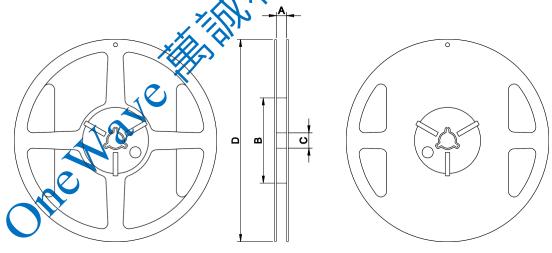
# **6.Packaging Information**

#### ◆ Tape Specification



W	Ao	Во	Ко	F	E	Do D1	Ро	P1	P2	t
32.0	3.60	18.6	1.37	14.2	1.75					0.35
±0.30	±0.15	±0.15	±0.10	±0.10	±0.10	±0.10 ±0.10	±0.10	±0.10	±0.10	±0.05

# ◆ Reel Specification: ("13", 00330 mm)



13" x 32 mm

Tape Width(mm)	A(mm)	B(mm)	C(mm)	D(mm)	Chip/Reel(pcs)	
32	32.6±0.5	99.5±1.0	13.5±0.5	330±1.0	4500	



#### 7. Storage and Transportation Information

#### **Storage Conditions**

To maintain the solderability of terminal electrodes:

- 1. Temperature and humidity conditions: -10~ 40°C and 30~70% RH.
- 2. Recommended products should be used within 6 months from the time of delivery.
- 3. The packaging material should be kept where no chlorine or sulfur exists in the air.

#### **Transportation Conditions**

The Nave Health

- Products should be handled with care to avoid damage of contamination from perspiration and skin oils.
- 2. The use of tweezers or vacuum pick up is strongly recommended for individual components.
- 3. Bulk handling should ensure that abrasion and mechanical shock are minimized.